



Title of Change:	CS33x1 Family Wafer Probe Site Transfer from ON Semiconductor, Roznov to ON Semiconductor Carmona				
Proposed first ship date:	30 August 2017 or earlier upon customer approval				
Contact information:	Contact your local ON Semiconductor Sales Office or <bill.fontes@onsemi.com>				
Samples:	Contact your local ON Semiconductor Sales Office				
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or < bill.fontes@onsemi.com >.				
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact <PCN.Support@onsemi.com>.				
Change Part Identification:	Date of change will be tracked by package marking date code.				
Change category:	<input type="checkbox"/> Wafer Fab Change <input type="checkbox"/> Assembly Change <input checked="" type="checkbox"/> Test Change <input type="checkbox"/> Other _____				
Change Sub-Category(s):	<input checked="" type="checkbox"/> Manufacturing Site Change/Addition <input type="checkbox"/> Material Change <input type="checkbox"/> Datasheet/Product Doc change <input type="checkbox"/> Manufacturing Process Change <input type="checkbox"/> Product specific change <input type="checkbox"/> Shipping/Packaging/Marking <input type="checkbox"/> Other: _____				
Sites Affected:	<input type="checkbox"/> All site(s) <input type="checkbox"/> not applicable <input checked="" type="checkbox"/> ON Semiconductor site(s) : ON Carmona, Philippines <input type="checkbox"/> External Foundry/Subcon site(s)				
Description and Purpose:	Transfer of wafer probing from the ON Semiconductor site in Roznov, Czech Republic to the ON Semiconductor site in Carmona, Philippines. Purpose of the change is to increase capacity and improve manufacturing flexibility while consolidating production in our wafer probe center of excellence in Carmona.				
Reliability Data Summary:	QV DEVICE NAME: CS3351YDR14G RMS: N/A PACKAGE: SOIC14				
	Test	Specification	Condition	Interval	Results
	ED	CS3351/D, CS3361/D	Electrical Parametric Correlation	n/a	pass
Electrical Characteristic Summary:	Electrical characteristics are not impacted.				
List of affected Standard Parts:					
	Part Number	Qualification Vehicle			
	CS3351YDR14G	CS3351YDR14G			
	CS3361YDR14G	CS3361YDR14G			